Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/098,542	NISHIMURO ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1732	

SEARCHED			
Class	Subclass	Date	Examiner
264	267	6/27/2005	EHL
	275		·
	279		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
east	6/27/2005	EHL
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